

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 287343US0PCT		SERIAL NO. 10/573,661	
LIST OF REFERENCES CITED BY APPLICANT		APPLICANT		Hiroshi TOKAIRIN , et al.			
		FILING DATE		March 28, 2006		GROUP	
<b>U.S. PATENT DOCUMENTS</b>							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA	US 6,582,837 B1	06/24/2003	Satoru TOGUCHI, et al. (corresponding to JP 11-228951 previously filed on 03/28/2006)			
	AB	US 2003/0215667 A1	11/20/2003	Shuang XIE			
	AC	US 2005/0214565 A1	09/29/2005	Hidetsugu IKEDA, et al.			
	AD						
	AE						
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	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
<b>FOREIGN PATENT DOCUMENTS</b>							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION		
	AO	WO 03/007658 A2	01/23/2003	WIPO	YES	NO	
	AP	WO 03/087023 A1	10/23/2003	WIPO (with English Abstract, corresponding to US 2005/0214565 A1 and JP 2003-306454 previously filed on 03/28/2006)			X
	AQ	EP 1 138 745 A1	10/04/2001	Europe			
	AR	EP 1 333 018 A1	08/06/2003	Europe			
	AS	EP 1 182 244 A1	02/27/2002	Europe			
	AT	EP 1 182 183 A1	02/27/2002	Europe			
	AU	EP 1 009 044 A2	06/14/2000	Europe (corresponding to JP 2000-182776 previously filed on 03/28/2006 and US 2002/28346 cited by examiner on 05/04/2009)			
	AV	WO 02/091814 A2	11/21/2002	WIPO			
<b>OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)</b>							
	AW						
	AX						
	AY						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner					Date Considered		
<p>*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</p>							